Search Notes					
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/805,297	WANG ET AL.	
Examiner	Art Unit	

Hieu Nguyen

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SEARCHED				
Class	Subclass	Date	Examiner	
330	133	7/29/2005	HN	
330	310	7/26/2005	HN	
330	253	7/26/2005	HN .	
330	254	7/26/2005	HN	
· 330	282	8/29/2005	HN	
330	51	8/1/2005	HN	
330	85	8/2/2005	HN	
330	86	8/2/2005	HN	
330	84	8/2/2005	HN	
327	416	8/3/2005	HN	
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INTERFERENCE SEARCHED				
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MOTTOLA STEVEN J	7/29/2005	HN
MOTTOLA STEVEN J	8/1/2005	HN
MOTTOLA STEVEN J	8/3/2005	HN
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